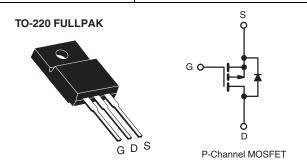


COMPLIANT

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 250			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	1.0		
Q _g (Max.) (nC)	38			
Q _{gs} (nC)	8.0			
Q _{gd} (nC)	18			
Configuration	Single			



FEATURES

- Advanced Process Technology
- · Dynamic dV/dt Rating
- 150 °C Operating Temperature
- · Fast Switching
- P-Channel
- · Fully Avalanche Rated
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION			
Package	TO-220 FULLPAK		
Lead (Pb)-free	IRFI9634GPbF		
Lead (FD)-liee	SiHFI9634G-E3		
SnPb	IRFI9634G		
SILL	SiHFI9634G		

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V_{DS}	- 250	V	
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current	$T_C = 25 ^{\circ}C$	l-	- 4.1	А	
	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I _D	- 2.6		
Pulsed Drain Current ^a	I_{DM}	- 16			
Linear Derating Factor			0.28	W/°C	
Single Pulse Avalanche Energy ^b		E _{AS}	520	mJ	
Repetitive Avalanche Current ^a		I _{AR}	- 4.1	Α	
Repetitive Avalanche Energy ^a		E _{AR}	3.5	mJ	
Maximum Power Dissipation	T _C = 25 °C	P_{D}	35	W	
Peak Diode Recovery dV/dtc		dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVIS SCIEW		1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 62 mH, R_G = 25 Ω , I_{AS} = 4.1 A (see fig. 12).
- c. $I_{SD} \le$ 4.1 A, $dI/dt \le$ 640 A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le$ 150 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI9634G, SiHFI9634G

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	=	3.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		- 250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	- 0.27	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		-	- 4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V		-	± 100	nA
Zarra Osta Walkana Burin G		V _{DS} =	V _{DS} = - 250 V, V _{GS} = 0 V		-	- 25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 200	V, V _{GS} = 0 V, T _J = 150 °C	-	-	- 250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 2.5 A ^b	-	-	1.0	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	- 50 V, I _D = - 4.1 A ^b	2.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	680	-	
Output Capacitance	C _{oss}	V _{DS} = -25 V, f = 1.0 MHz, see fig. 5		-	170	-	_
Reverse Transfer Capacitance	C _{rss}			-	40	-	pF
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Q_g		I _D = -4.1 A, V _{DS} = -200 V, see fig. 6 and 13 ^b	ı	-	38	nC
Gate-Source Charge	Q_{gs}	V _{GS} = - 10 V		1	-	8.0	
Gate-Drain Charge	Q_{gd}			-	-	18	
Turn-On Delay Time	t _{d(on)}	V_{DD} = - 130 V, I_{D} = - 4.1 A, R_{G} = 12 Ω , R_{D} = 31 Ω , see fig. 10 ^b		-	12	-	- ns
Rise Time	t _r			-	23	-	
Turn-Off Delay Time	t _{d(off)}			-	34	-	
Fall Time	t _f			-	21	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	m1.1
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 4.1	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 16	,,
Body Diode Voltage	V_{SD}	T _J = 25 °C,	$T_J = 25 ^{\circ}\text{C}, I_S = -4.1 \text{A}, V_{GS} = 0 V^b$		-	- 6.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = -4.1 \text{A}, \text{dl/dt} = -100 \text{A/}\mu\text{s}^b$		-	190	290	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.5	2.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

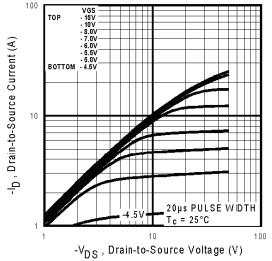


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

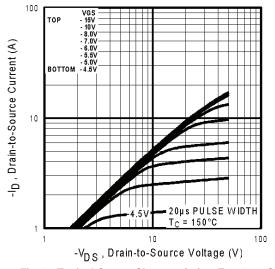


Fig. 2 - Typical Output Characteristics, T $_{\text{C}}$ = 150 $^{\circ}\text{C}$

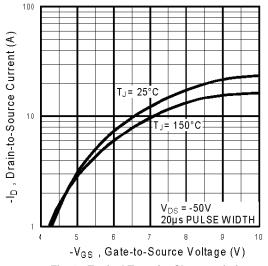


Fig. 3 - Typical Transfer Characteristics

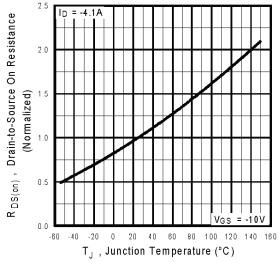


Fig. 4 - Normalized On-Resistance vs. Temperature



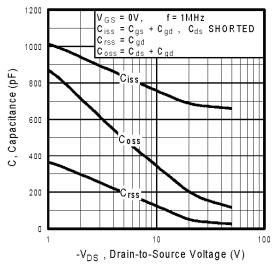


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

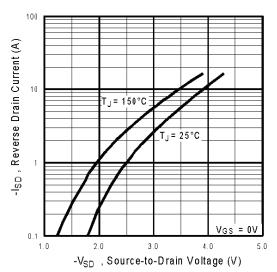


Fig. 7 - Typical Source-Drain Diode Forward Voltage

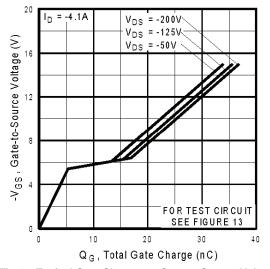


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

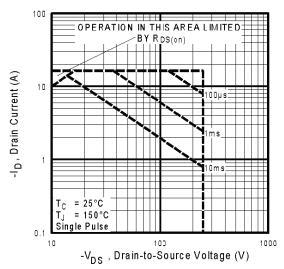


Fig. 8 - Maximum Safe Operating Area

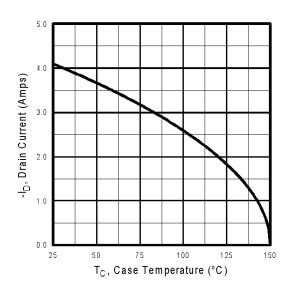


Fig. 9 - Maximum Drain Current vs. Case Temperature

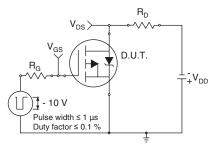


Fig. 10a - Switching Time Test Circuit

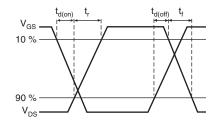


Fig. 10b - Switching Time Waveforms

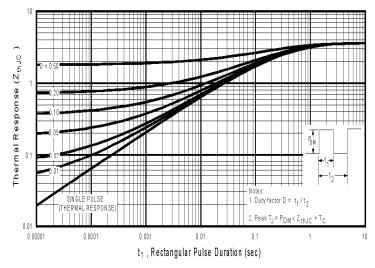


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

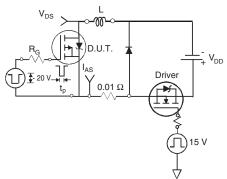


Fig. 12a - Unclamped Inductive Test Circuit

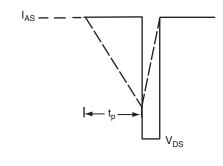


Fig. 12b - Unclamped Inductive Waveforms



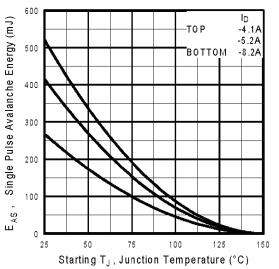


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

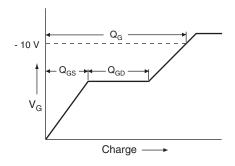


Fig. 13a - Basic Gate Charge Waveform

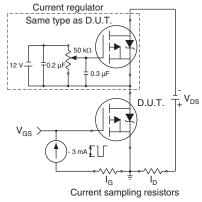
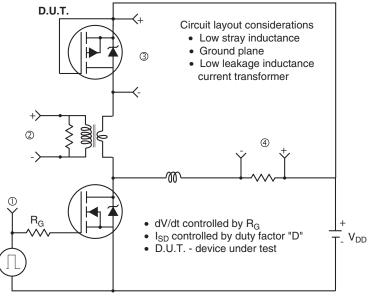


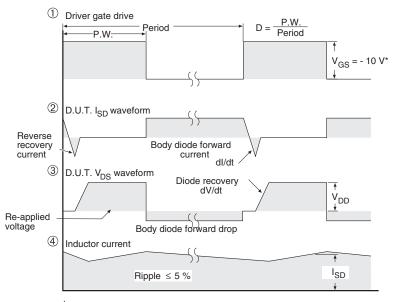
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



* $V_{GS} = -5 \text{ V}$ for logic level and -3 V drive devices

Fig. 14 - For P-Channel

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